

Communications

Ba₅Nb₄O₁₅ Ceramics with Temperature-Stable High Dielectric Constant and Low Microwave Loss

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Dielectric properties at microwave frequency region of the five-layered compound Ba₅Nb₄O₁₅ prepared by the conventional solid state reaction method were investigated. Ba₅Nb₄O₁₅ has excellent microwave dielectric characteristics; $\epsilon_r=38$, $Q=7500$ at 10 GHz, and $\tau_r=+50$ ppm/K. Since this compound has a high dielectric constant, high Q and sufficiently stable characteristics, it is useful for the applications at microwave frequencies.

Key words : Microwave dielectrics, Ba₅Nb₄O₁₅, Layered compound

I. Introduction

Several kinds of dielectric ceramics are used for microwave applications.^{1,3)} For the microwave dielectric-resonator applications, high dielectric constant (ϵ_r), low dielectric loss (a high unloaded Q), and a small temperature coefficient of resonance frequency (τ_r) are required. Until now, the microwave dielectric properties were vigorously investigated for the B-site cation ordering complex perovskite with a high Q value^{4,5)} and for the relation between r and the microstructure of the ceramics.^{6,7)}

A number of perovskite-related compounds having the general formula A₅B₄O₁₅, especially Ba₅Nb₄O₁₅, is of interest because these compounds are very attractive for optical studies.⁸⁾ Since there are four Nb⁵⁺ ions on each five-layer sequence, there is an empty octahedra which avoids direct face sharing on the NbO₆ sublattice. This configuration implies strong anharmonicity making these compounds very attractive for optical studies. In fact, a recent far-infrared reflectivity measurement on Ba₅Nb₄O₁₅ predicts that this perovskite-related compound is a very attractive material to be applied for microwave dielectric resonators.⁹⁾

Far-infrared reflectance spectra of several materials used for microwave applications have recently been measured and analyzed according to the classical dispersion theory.^{9,10)} Experimentally, following relation holds between dielectric loss ($\tan\delta$) and reflectance data obtained by far-infrared reflectivity measurements.¹¹⁾

$$\tan \delta_j = \frac{\Delta \epsilon_j (\gamma_{TO} \omega) / \Omega_{TO}^2}{\epsilon_\infty + \sum_i \Delta \epsilon_i} \propto \frac{\gamma_{TO} \omega}{\Omega_{TO}^2} \quad (1)$$

where $\Delta \epsilon_j$ is the oscillator strength, Ω_{TO} and γ_{TO} are transverse optic (TO) mode frequency and its damping constant, respectively. The dielectric constant ϵ_∞ is caused by electronic polarization at higher frequencies.

We have calculate the $\tan\delta$ for Ba₅Nb₄O₁₅ at microwave frequencies using far-infrared reflectivity measurement results by Massa *et al.*⁹⁾ Then, the values of $\tan\delta$ calculated from Eq. (1) is found to be 4.443×10^{-5} , this calculating result thus implies that Ba₅Nb₄O₁₅ expect to be utilized for the microwave dielectric resonators. In this study, we have investigated the dielectric properties of B-site defect perovskite-related Ba₅Nb₄O₁₅ ceramics at microwave frequency.

Polycrystalline sample of Ba₅Nb₄O₁₅ was prepared by conventional solid state reaction. The starting materials were BaCO₃ and Nb₂O₅ powders with high purity (3N grade). The mixture of powders were calcined in air at 1473 K for 12 h. Ground again, well mixed, and pressed into pellets. Pellets were fired on a platinum foil at 1723 K 12 h in air. The crystal structure was examined using X-ray diffraction and the grains of the ceramics was observed by SEM. The sintered density of the ceramic was measured by water immersion method.

Flat surface of specimen was coated with a sliver for an electrode to measure the low frequency dielectric properties. Using YHP 4192A impedance analyzer, capacitances were obtained as a functions of temperature by four-terminal pair ac impedance measurements with frequency range from 5 kHz to 600 kHz and in the temperature range from 77 K to 700 K. The measured values of capacitances was correlated by calibrating the capacitances of leads as zero. Microwave dielectric pro-

properties were measured by means of the dielectric resonator cavity method in the $TE_{01\delta}$ mode.^{12,13} The temperature coefficient of resonant frequency, τ_f , was measured in the temperature range from 240 K to 353 K and the resonant frequency was about 10 GHz.

The crystal structure in $Ba_5Nb_4O_{15}$ is hexagonal perovskite-related structure with lattice constant $a=5.7943\text{\AA}$ and $c=11.783\text{\AA}$, which agree well with data in JCPDS (Code; #14-0028). The grain size was 7 μm and density of the sintered specimen was about 87% of theoretical value.

Low frequency dielectric data for $Ba_5Nb_4O_{15}$ are shown in Fig. 1, dielectric constant (a) and $\tan\delta$ (b) as a function of temperature are shown at various frequencies. The dielectric constant and $\tan\delta$ increases smoothly with the increasing temperature at various frequency. There are no dielectric anomalies peaks observed. The room temperature dielectric constant is 41.2 at 600 kHz and the temperature dependence of dielectric constant ($TC\epsilon_r$) is calculated as about -106 ppm/K in temperature range $250\text{ K} \leq T \leq 350\text{ K}$.

The Q value was 7500, the ϵ_r was estimated as 38 at 10 GHz, and the τ_f was +50 ppm/K. The microwave dielectric constant are determined by the combination of ionic and electronic polarization. The electronic polarization value of $Ba_5Nb_4O_{15}$ obtained by Massa *et al.*⁶ was about 3.5, however, the contribution of electronic polarization was very small compare to ionic polarization.

The investigation of $TC\epsilon_r$ at low frequency is important because the $TC\epsilon_r$ of a specified compounds is closely associated with τ_f of a dielectric resonator at mi-

crowave frequency. An outstanding feature in the properties of the dielectrics examined is a considerable deviation of the $TC\epsilon_r$ from a simple relation which have been observed in many ceramic dielectrics. Based on the differentiated form of the Clausius-Mosotti equation, the variation in dielectric constant with temperature can be related to temperature variations of material's dimensions (linear expansion coefficient, α_L), and of the polarizability (α) of the volume (V) containing N polarizable units as follow:¹⁴

$$TC\epsilon_r = \frac{\epsilon_r}{3} \left(\frac{1}{\alpha} \frac{\partial\alpha}{\partial T} - 3\alpha_L \right) \quad (2)$$

If $1/\alpha (\partial\alpha/\partial T)$ is negligibly small, Eq. (2) gives $TC\epsilon_r = -\epsilon_r \cdot \alpha_L$. This simplified relation can hold for a number of dielectrics with $\epsilon_r \geq 30$.¹⁵ The τ_f is approximately expressed as $\tau_f = -\alpha_L \cdot TC\epsilon_r / 2$. The $TC\epsilon_r$ for $Ba_5Nb_4O_{15}$ exhibited a considerable deviation from a simple relation of $TC\epsilon_r = -\epsilon_r \cdot \alpha_L$. This results suggested that the temperature coefficient of polarizability might be comparable to or considerably exceed the volume expansion coefficient, if the application of the Clausius-Mosotti equation is allowed.

There are many factors to influence the Q value, especially in the high Q ceramics, such as crystal structure, sintered density, impurities and defects. From the viewpoint of the crystal structure, it is generally accepted that the characteristics of microwave dielectrics are strongly correlated to crystal symmetry. Dielectric

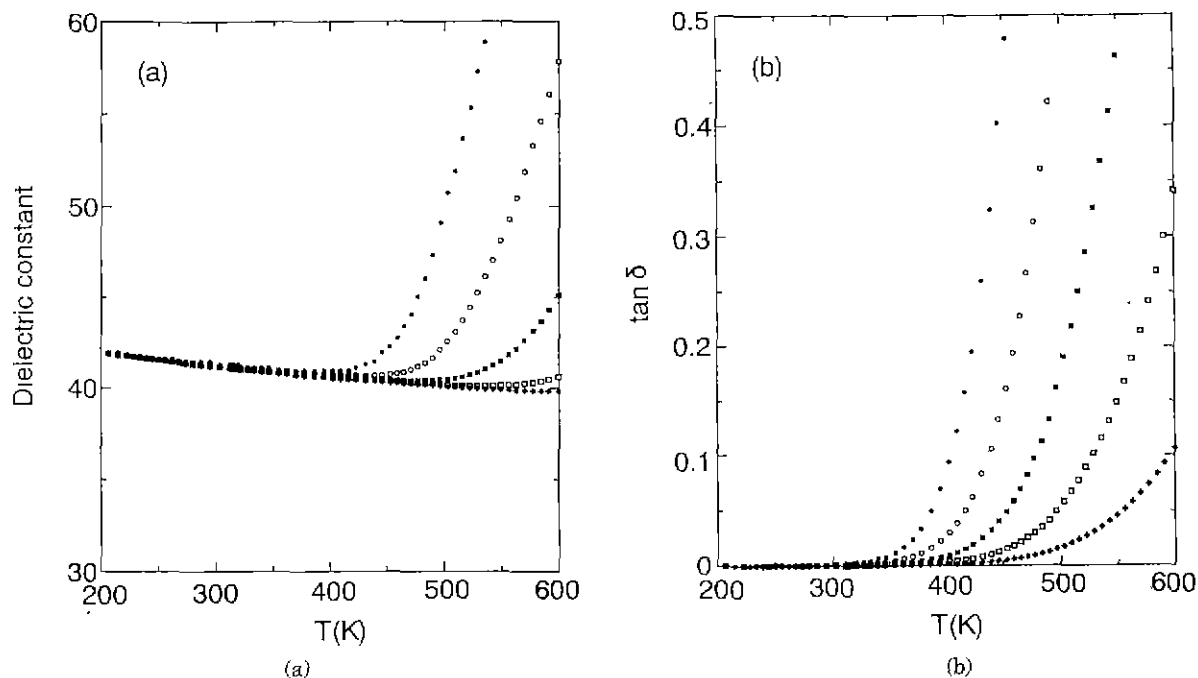


Fig. 1. Temperature dependence of dielectric constant (a) and $\tan\delta$ (b) for $Ba_5Nb_4O_{15}$ measured at various frequencies. Open circles represent the results at the applied frequency 5 kHz; solid circles, 16 kHz; solid square, 54 kHz; squares, 180 kHz; and solid triangles, 600 kHz.

Table 1. Comparison with Microwave Dielectric Properties for Ba₅Nb₄O₁₅ and Other Dielectric Resonators

Compounds	ϵ_r	Q	τ_f (ppm/K)	f_r (GHz)	Ref.
Ba(Mg _{1/3} Ta _{2/3})O ₃	25	16800	2.7	10.5	4
Ba(Zn _{1/3} Ta _{2/3})O ₃	30	14000	0	12.0	5
BaTi ₄ O ₉	36	4900	16	10.3	13
Ba ₂ Ti ₃ O ₂₀	37	5300	-6.0	10.7	13
Ba ₅ Nb ₄ O ₁₅	38	7500	50	10.0	this work

characteristics at microwave frequency of Ba₅Nb₄O₁₅ and other resonator reported by several works are summarized in Table 1. Ba₅Nb₄O₁₅ shows relatively low Q value compare to 1:2 B -site ordering type perovskite. This result means that the very high Q value for $A(B_{1/3}^{II} B_{2/3}^I)O_3$ is due to the B -site order arrangement of the cations in the perovskite structure. Although 1:2 B -site ordering perovskites and Ba₅Nb₄O₁₅ have a same $D_{3d}^5-P_{3m1}$ crystal space group which is determined by raman-spectra,¹⁶ Ba₅Nb₄O₁₅ have a lower symmetry structure due to the empty octahedron.¹⁶ Because these empty octahedron in Ba₅Nb₄O₁₅ play a role of the intrinsic defect. However, although it is B -site defect perovskite-related compound, Ba₅Nb₄O₁₅ show outstanding microwave unloaded Q value.

It seems that the five layer perovskite-related ceramics containing Nb⁵⁺ has potential use for dielectric resonators with high Q value and dielectric constant. Using this low loss ceramics, one can design a high quality microwave band pass filter or stabilize a frequency in microwave oscillation.

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